

Notice of References Cited	Application/Control No. 10/694,909	Applicant(s)/Patent Under Reexamination SASAKI, GEN	
	Examiner Nhan T. Tran	Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,166,781	12-2000	Kwak et al.	348/254
*	B	US-5,661,575	08-1997	Yamashita et al.	358/519
*	C	US-5,473,373	12-1995	Hwung et al.	348/254
*	D	US-5,361,094	11-1994	Jang, Ji-hoon	348/254
*	E	US-5,706,058	01-1998	Okada, Hidefumi	348/674
*	F	US-5,691,821	11-1997	Hieda et al.	348/674
*	G	US-6,181,368	01-2001	Takahashi et al.	348/70
*	H	US-4,805,013	02-1989	Dei et al.	358/519
*	I	US-5,473,372	12-1995	Nobuoka et al.	348/254
*	J	US-5,828,986	10-1998	Horigome et al.	348/552
*	K	US-5,153,730	10-1992	Nagasaki et al.	348/231.6
*	L	US-6,426,771	07-2002	Kosugi, Masato	348/222.1
*	M	US-4,931,864	06-1990	Kawamura et al.	358/519

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.